

Notice of References Cited

Application/Control No.

09/664,435

Applicant(s)/Patent Under

Reexamination

IWADE ET AL.

Examiner

Ryan R Yang

Art Unit

2672

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0047843	04-2002	Higashiyama et al.	345/426
	B	US-			
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	D	US-			
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FOREIGN PATENT DOCUMENTS

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